Modified Form PTO/SB/08A

Substitute for form 1449A/PTO

INFORMATION DISCLOSURE

Modified Form PTO/SB/08A

Complete If Known

Application Number 09/846,490

Filing Date April 30, 2001

	ORMATION I			Filing Date	April 30, 2001
STA	TEMENT BY	APPL	<b>ICANT</b>	First Named Inventor	Benjamin Eldridge et al.
1	(use as many sheets	as necess	ary)	Group Art Unit	3729
	`		• /	Examiner Name	C. Arbes
Sheet	2	of	2	Attorney Docket No.	P6D2-US

	OTE	IER PRIOR ART – NONPATENT LITERATURE DOCUMENTS	
Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T <sup>2</sup>
cp	18	Lee, "Design and Fabrication of a monolithic High-Density Probe Card for High-Frequency on-Wafer Testing", IEEE, IEDM 89-289-292, (1989).	
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<sup>&</sup>lt;sup>1</sup>Unique citation designation number. <sup>2</sup>Applicant is to place a check mark here if English language Translation is attached.

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			U.S. P	ATENT DOCUMENTS	3		
Examiner Initials	Cite No.1	U.S. Patent Number	Document Kind Code <sup>2</sup>	Name of Patentee or Applicant	Publication Date	Related	Copy Enclosed
Ola	1	3493858		D.G. Baron et al.	2/3/70		No
Oya	2	3806801		Bove	4/23/74		No
Oja	3	3911361		Bove et al.	10/7/75		No
Da	4	4423376		Brynes et al.	12/27/83		No
019	5	4837622		Whann et al.	6/6/89		No
CIA	6	4916002		Carver	4/10/90		No
ota	7	5059898		Barsotti et al.	10/22/91		No
CV	8	5177439		Liu et al.	1/5/93		No
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Examiner Initials	Cite No.1	Forei Office <sup>3</sup>	gn Patent Docum Number Kind	nent Code <sup>3</sup>	Name of Patentee or Applicant	Publication Date	Copy Enclosed	Te
99.	12	JP	1150862		Mitsubishi Electric Corp.	6/13/89	Yes	Х
ge	13	JP	6-151532		Tokyo Electron Yamanashi KK	5/31/94	Hos onl	X
QG .	14	JP	63-293934		Hitachi	11/30/88	Yes	X
ga	15	JP	6-84455		Canon Kabushiki Kaisha	3/25/94	Yes	Х
Qu	16	JP	7-7052		Seiko-Epson Corp	1/10/95	Yes	Х
14	17	EP	508707		Texas Instruments	10/14/92	Yes	X

Signature C. J. Chris Considered \$ 15.65		
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				Application Number	09/846,490
	ORMATION I			Filing Date	4/30/01
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	` ,			Examiner Name	C. Arbes
Sheet	1	of	1	Attorney Docket No.	P6D2-US

			U.S. PATE	NT DOCUMENTS		
Examiner Initials	Cite No.1	U.S. Patent Number	Document Kind Code <sup>2</sup>	Name of Patentee or Applicant	Publication Date	Relevant Portions
9A	1	3,963,986	Adia Code	Morton et al.	6/15/76	Tordons
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Examiner Initials*	Cite No.1	Forei Office <sup>3</sup>	gn Patent I Number <sup>4</sup>	Docume Kind C		Name of Patentee or Applicant	Publication Date	Relevant Portions	Te
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ya_	3	Korea Institute of Machinery & Materials "Development of Manufacturing Process for Membrane Probe Card", Ministry of Science and Technology, pp.1-62, (1992).	
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